# **Power MOSFET**

# 30 V, 70 A, Single N-Channel, SO-8 FL

# **Features**

- Optimized for Portable Applications with 5 V Gate Drive
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

# **Applications**

- CPU Power Delivery
- DC-DC Converters
- Notebook Battery Management

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Para	Symbol	Value	Unit		
Drain-to-Source Volt	V <sub>DSS</sub>	30	V		
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Current R <sub>0JA</sub>		T <sub>A</sub> = 25°C	I <sub>D</sub>	17.1	Α
(Note 1)		T <sub>A</sub> = 100°C		10.9	
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.6	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	30	Α
Current R <sub>θJA</sub> ≤ 10 s (Note 1)		T <sub>A</sub> = 100°C		19	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	8.1	W
Continuous Drain	State	T <sub>A</sub> = 25°C	Ι <sub>D</sub>	10.2	Α
Current R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 100°C		6.5	
Power Dissipation $R_{\theta JA}$ (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.92	W
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	70	Α
Current R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 85°C		44	
Power Dissipation $R_{\theta JC}$ (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	43	W
Pulsed Drain Current	ain $T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	210	Α
Current Limited by Pa	Current Limited by Package T <sub>A</sub> = 25°C			100	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to +150	°C
Source Current (Body Diode)			I <sub>S</sub>	40	Α
Drain to Source DV/DT			dV/d <sub>t</sub>	6.5	V/ns
Single Pulse Drain-to-Source Avalanche Energy ( $T_J$ = 25°C, $V_{DD}$ = 50 V, $V_{GS}$ = 10 V, $I_L$ = 37 $A_{pk}$ , $L$ = 0.1 mH, $R_G$ = 25 $\Omega$ )			E <sub>AS</sub>	68.5	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

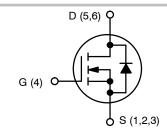
- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.



# ON Semiconductor®

# http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
30 V	4.0 m $\Omega$ @ 10 V	70 A	
	6.0 mΩ @ 4.5 V	707	



**N-CHANNEL MOSFET** 

# 1

# SO-8 FLAT LEAD CASE 488AA STYLE 1

S 4957N AYWZZ G D

MARKING DIAGRAM

A = Assembly Location
Y = Year
W = Work Week
ZZ = Lot Traceability

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFS4957NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4957NT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.9	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	48	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{ heta JA}$	135	30/00
Junction-to-Ambient – (t ≤ 10 s) (Note 3)	$R_{ heta JA}$	14.8	

- 3. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 4. Surface-mounted on FR4 board using the minimum recommended pad size.

# **ELECTRICAL CHARACTERISTICS** (T<sub>.I</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS						•	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage (transient)	V <sub>(BR)DSSt</sub>	V <sub>GS</sub> = 0 V, I <sub>D(aval)</sub> = 15.5 A, T <sub>case</sub> = 25°C, t <sub>transient</sub> = 100 ns		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				15		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	T <sub>J</sub> = 25°C			1.0	μΑ
			T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.32	1.63	2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		3.2	4.0	
			I <sub>D</sub> = 15 A		3.2		mΩ
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		4.8	6.0	
			I <sub>D</sub> = 15 A		4.8		
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			37		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C <sub>ISS</sub>				2516		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V			840		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				25		
Capacitance Ratio	C <sub>RSS</sub> / C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15 V, f = 1 MHz			0.010	0.020	
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			15.9		
Threshold Gate Charge	Q <sub>G(TH)</sub>				4.0		
Gate-to-Source Charge	$Q_{GS}$				7.6		nC
Gate-to-Drain Charge	$Q_{GD}$				2.2		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			31		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 5. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.
- 6. Switching characteristics are independent of operating junction temperatures.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

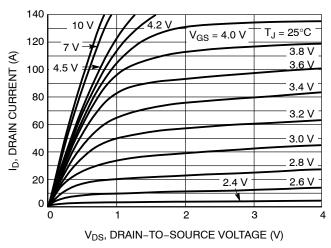
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (Note 6)							
Turn-On Delay Time	t <sub>d(ON)</sub>				14.4		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V,			25		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 15 \text{ A}, R_G =$	: 3.0 Ω		23.4		ns
Fall Time	t <sub>f</sub>				5.7		1
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			10.6		ns
Rise Time	t <sub>r</sub>				21.1		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				29.3		
Fall Time	t <sub>f</sub>				4.0		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 \text{ V},$ $I_{S} = 30 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$	$T_J = 25^{\circ}C$		0.88	1.1	
				0.78		V	
Reverse Recovery Time	t <sub>RR</sub>				39		
Charge Time	t <sub>a</sub>	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			19		ns
Discharge Time	t <sub>b</sub>				20		
Reverse Recovery Charge	Q <sub>RR</sub>				35		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>	T <sub>A</sub> = 25°C			0.93		nΗ
Drain Inductance	L <sub>D</sub>				0.005		nH
Gate Inductance	L <sub>G</sub>				1.84		nΗ
Gate Resistance	$R_{G}$				1.1	2.0	Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

6. Switching characteristics are independent of operating junction temperatures.

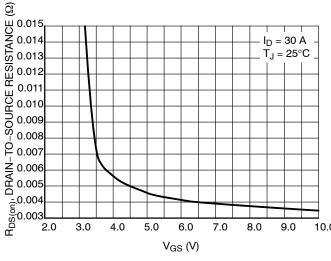
# **TYPICAL CHARACTERISTICS**



120  $V_{DS} = 10 \text{ V}$ 100 ID, DRAIN CURRENT (A) 80 60  $T_J = 25^{\circ}C$ 40 20  $T_J = 125^{\circ}C$  $T_J = -55^{\circ}C$ 0 1.0 2.0 2.5 3.0 3.5 4.0 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



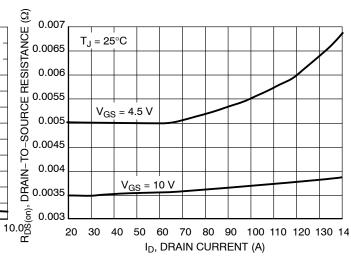
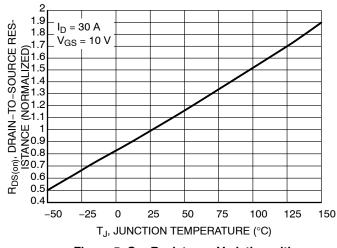


Figure 3. On-Resistance vs. V<sub>GS</sub>

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



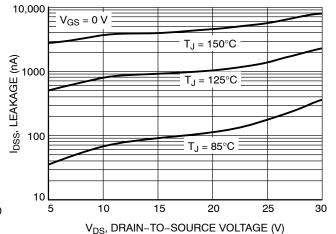


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

# **TYPICAL CHARACTERISTICS**

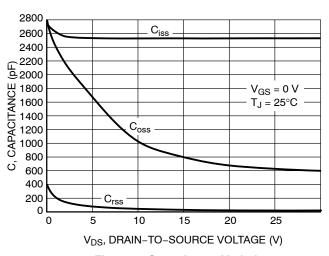


Figure 7. Capacitance Variation

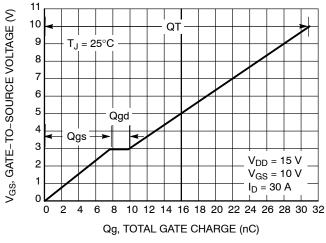


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

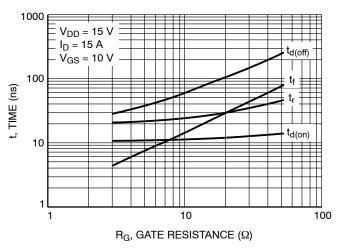


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

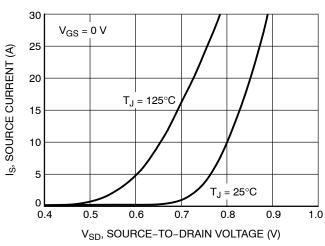


Figure 10. Diode Forward Voltage vs. Current

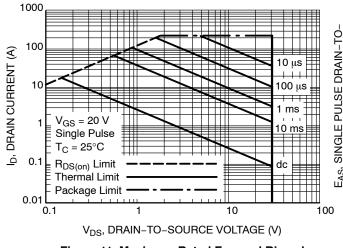


Figure 11. Maximum Rated Forward Biased Safe Operating Area

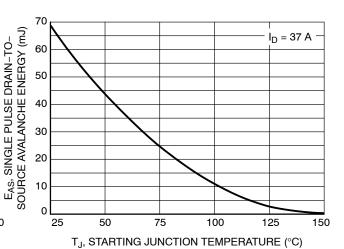


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

# **TYPICAL CHARACTERISTICS**

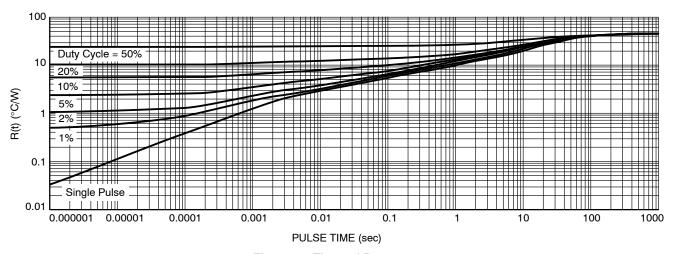


Figure 13. Thermal Response

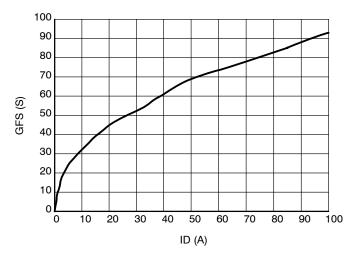
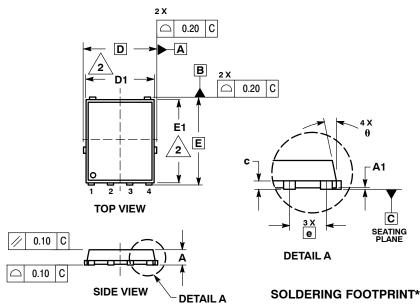


Figure 14. GFS vs. ID

### PACKAGE DIMENSIONS



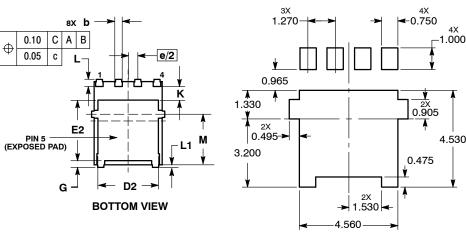


#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994
- CONTROLLING DIMENSION: MILLIMETER. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	0.90	1.00	1.10			
A1	0.00		0.05			
b	0.33	0.41	0.51			
С	0.23	0.28	0.33			
D		5.15 BSC	;			
D1	4.50	4.90	5.10			
D2	3.50		4.22			
E		6.15 BSC				
E1	5.50	5.80	6.10			
E2	3.45		4.30			
е		1.27 BSC				
G	0.51	0.61	0.71			
K	1.20	1.35	1.50			
L	0.51	0.61	0.71			
L1	0.05	0.17	0.20			
M	3.00	3.40	3.80			
θ	0 °		12 °			

- STYLE 1: PIN 1. SOURCE
  - SOURCE
     SOURCE
  - GATE
  - 5. DRAIN



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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